

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

TAKAHASHI ET AL.

Examiner

SHEETAL R. RANGREJ

Art Unit

3686

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,441,047	08-1995	David et al.	600/483
*	B US-2008/0021740	01-2008	Beane et al.	705/003
C	US-			
D	US-			
E	US-			
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H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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